Search Notes

Application/Control No	Applicant(s)/Patent Under Reexamination
10567474	MICHL, ANDREAS
Examiner	Art Unit
JAE Y LEE	2619

SEARCHED				
Class	Subclass	Date	Examiner	
370	241,252,474	9/11/2008	Jae Y Lee	

SEARCH NOTES			
Search Notes	Date	Examiner	
service access point, SAP, OSI, analyze, monitor, sniffer, mobile	9/11/2008	Jae Y Lee	
Limited search using class/subclass 370/241,252,474	9/11/2008	Jae Y Lee	
Inventor search: Andreas Michl	9/11/2008	Jae Y Lee	
NPL search using the terms: service access point, SAP, OSI, analyze, monitor, sniffer, mobileby Google	9/11/2008	Jae Y Lee	
Consulted with primary examiner Steven H. Nguyen	9/11/2008		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20080911